



Bands and electronic devices

Electrons and holes in bands

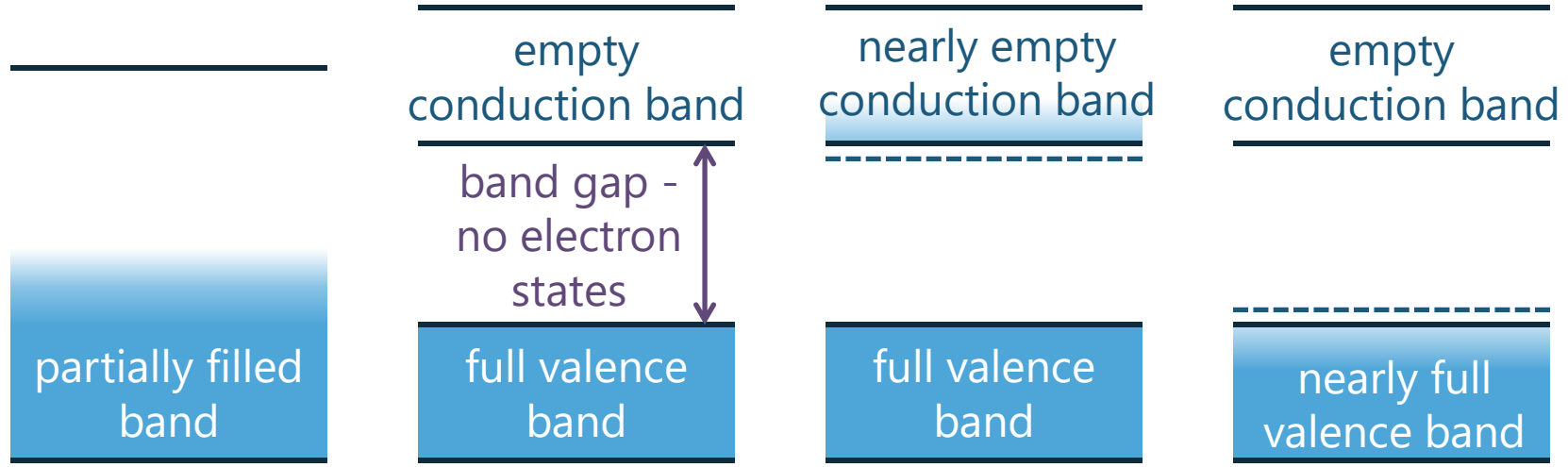
Modern physics for engineers

David Miller

Metals, semiconductors and insulators - revision

Metals, insulators and semiconductors - revision

Electron energy



Metal

Insulator

n-doped
semiconductor

p-doped
semiconductor

electrons can
move to new
states
hence conducts
electricity

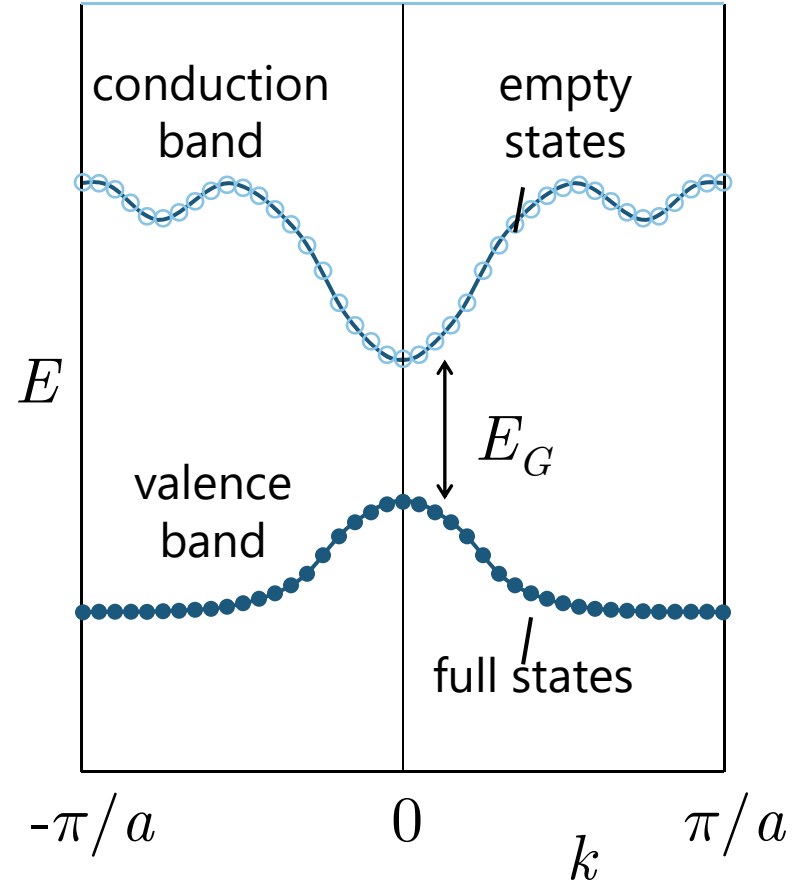
electrons in full
bands cannot
move to new
states
does not conduct

added free
electrons in
conduction band
conduct

missing free
electrons in
valence band
allow conduction

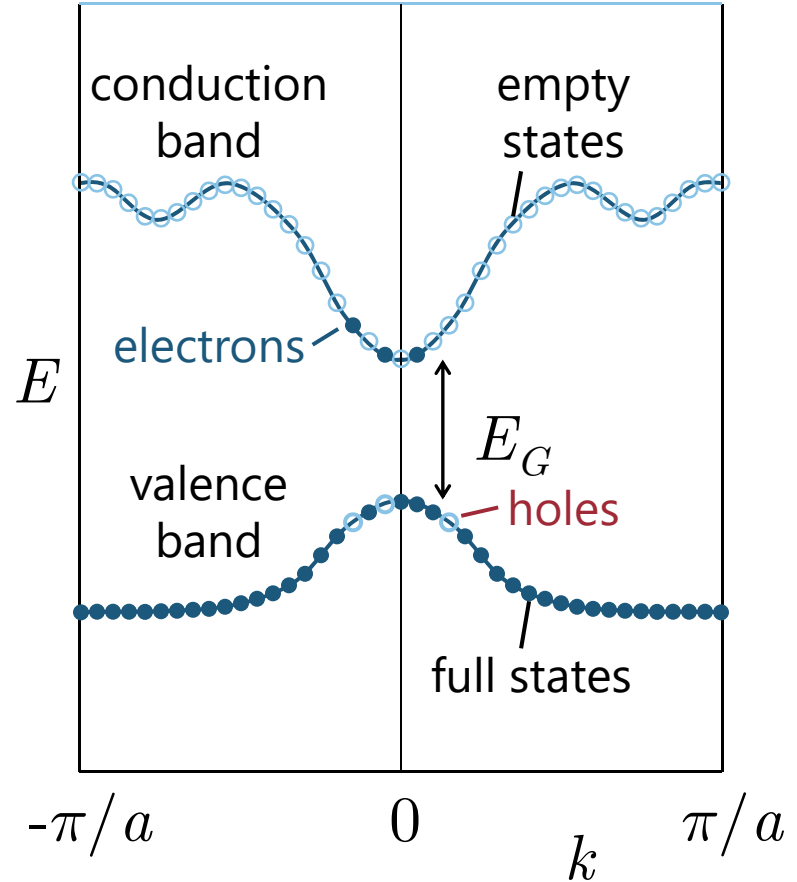
Semiconductors and insulators - revision

Semiconductors and insulators
have an (almost) completely
full band
the valence band
separated by a "bandgap"
energy E_G
from an (almost) completely
empty band
the conduction band



Semiconductors

Now we look at behaviors of electrons (and holes) in bands
for example, for "transport"
the movement of charge for
conducting electrical current
and some of the consequences
of thermal distributions of them
for devices



Transport in semiconductors

Transport of electrons

For an electron in some parabolic minimum (or maximum)

we can rewrite $E = \frac{\hbar^2 k^2}{2m_{eff}}$

in terms of "crystal" momentum $p_C = \hbar k$ as

$$E = \frac{p_C^2}{2m_{eff}}$$

Then $\frac{dE}{dp_C} = \frac{p_C}{m_{eff}}$

Transport of electrons

With $\frac{dE}{dp_C} = \frac{p_C}{m_{eff}}$

then thinking of a velocity v_g such that $p_C = m_{eff} v_g$
we have for this velocity at which we expect the
particle is moving

$$v_g = \frac{dE}{dp_C}$$

This particular velocity v_g
is called the "group velocity"

Transport of electrons

Suppose we apply an “external” force F to the particle
such as from an electric field

Then the work done in applying the force through a
distance dx is

$$dE = Fdx$$

The distance dx equals

the group velocity v_g times

the time, dt , for which the force is applied

so we have

$$dE = Fdx = Fv_g dt$$

Transport of electrons

Hence

$$F = \frac{1}{v_g} \frac{dE}{dt} = \frac{1}{v_g} \frac{dE}{dp_C} \frac{dp_C}{dt}$$

or, using $v_g = dE / dp_C$

$$F = \frac{dp_C}{dt} \equiv \frac{d(\hbar k)}{dt}$$

So applying a force to an electron leads to

“force is equal to rate of change of (crystal) momentum”

This crystal momentum behaves like the momentum of an effective particle of mass m_{eff}

In this picture, applying a force

moves the electron steadily through the Brillouin zone

Ballistic transport of electrons



This kind of transport

where the electron is continuously
accelerated by the applied field

is called "ballistic transport"

It does exist in materials like
semiconductors

and is part of device analysis

but it only applies for

very short distances

or very short time-scales

Drift transport of electrons



More typically, the electron is accelerated ("ballistically")

for some average or effective
"scattering" time t_s

then the electron is scattered by
some collision

with other electrons

or crystal vibrations ("phonons")

or crystal impurities or defects

Drift transport of electrons



In the “drift” model

the scattering events are random

but so strong that, on the average

the electron velocity is

randomized by them

So the average electron velocity after
the collision is zero

because it could just as well be
going in any direction

Drift transport of electrons

Specifically, for an electric field of magnitude \mathcal{E}

the magnitude of the force on an electron is $F = e\mathcal{E}$

If we accelerate (from zero velocity)

using such a force for a time t_s

the peak momentum just before scattering will be

$$p_C = \frac{dp_C}{dt} t_s = Ft_s = e\mathcal{E} t_s = m_{eff} v_{peak}$$

The average velocity is half this peak value

$$v_{av} = \frac{et_s}{2m_{eff}} \mathcal{E}$$

Drift transport of electrons

So, in drift transport, the average velocity of the electron
is proportional to the applied electric field \mathcal{E}
and the average velocity is called the “drift velocity”

Such transport is often written as

$$v_{av} = \mu_e \mathcal{E}$$

where

$$\mu_e = \frac{et_s}{2m_{eff}}$$

is called the “mobility”

This gives rise to behavior like Ohm’s law
with current proportional to the voltage

Hole transport in semiconductors

Holes



At a maximum at the top of the valence band

the electron effective mass is negative

Electrons would go backwards if pushed

Though counter-intuitive, this is correct

The group velocity can be "backwards"

e.g., in the "wrong" direction when pushed by an electric field

Holes



For a set of electrons in states near
such a negative effective mass
maximum

but with a state (or wave packet of
states) not occupied

that “empty” state or wave packet
will move along

in the same “backwards”
direction as the electrons do

Holes



This “absence of an electron”
wavepacket

is moving in the wrong direction for
electron electrical current

but in the correct direction for the
electrical current of a positively
charged particle

in this electric field

Holes



So we can pretend this "absence-of-an-electron"

in a "negative electron effective mass" maximum

behaves like a positive charge with a positive mass

going in the "correct" direction

Holes

This “cancellation of two minus signs”
exchanging an absence of negative
charge with a negative mass

for an effective positive charge with
a positive mass (of the same
magnitude)

lets us define the idea of a “hole”
with positive charge and mass

Hole transport otherwise obeys the
same behaviors as electron transport



Hole energies

Holes



We can think of the hole kinetic energy as being positive

if we look at the band diagram upside down

just as we can similarly think of positive hole energies in the hole Fermi-Dirac distribution when looking at the band diagram upside down

Holes

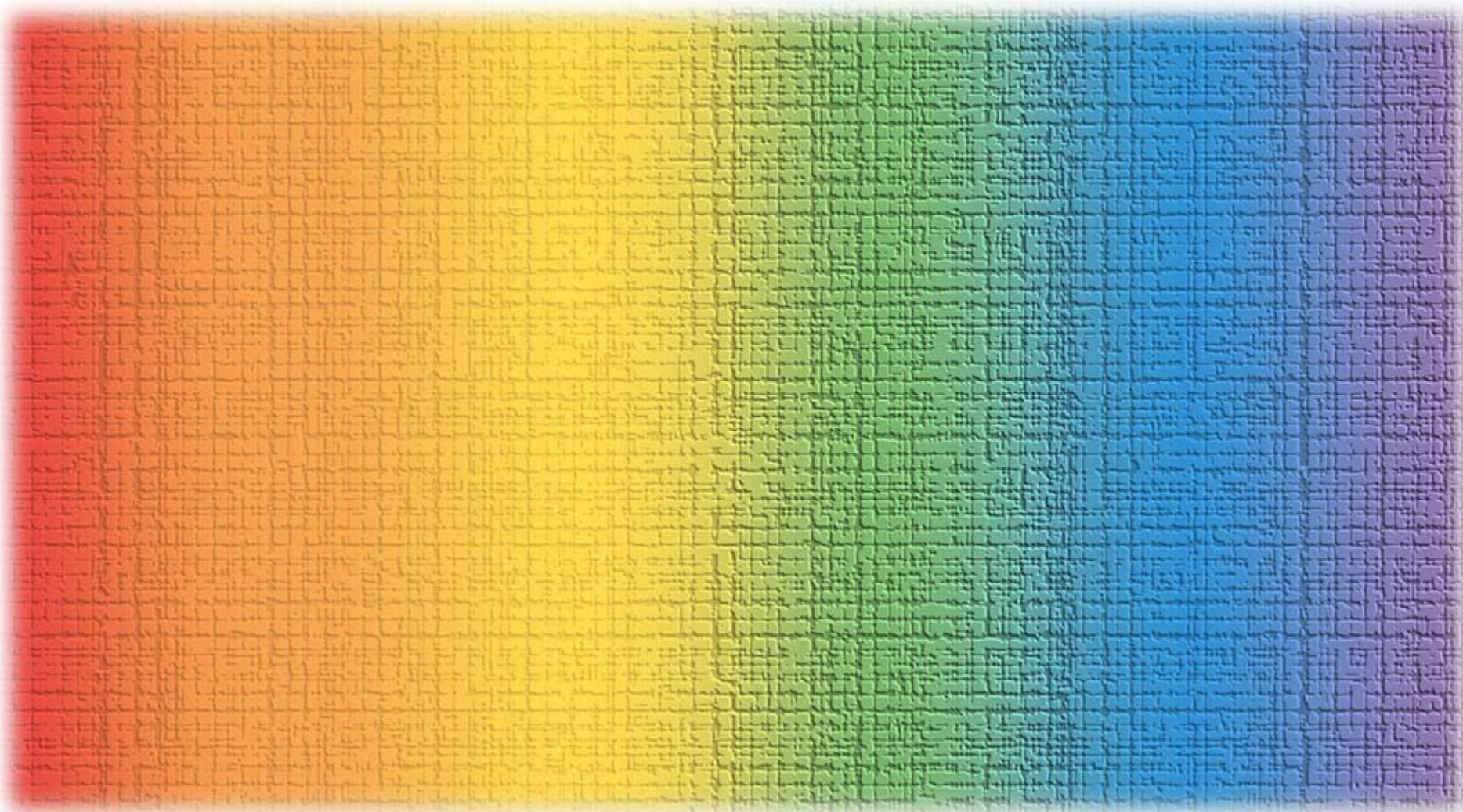


Generally, for holes

we “stand on our heads” in looking
at energy diagrams

just as we would for thinking
about

the energy of bubbles in a liquid
which is a higher energy for a
bubble “deeper” in the liquid





Bands and electronic devices

Semiconductor doping and diodes

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Doping in semiconductors

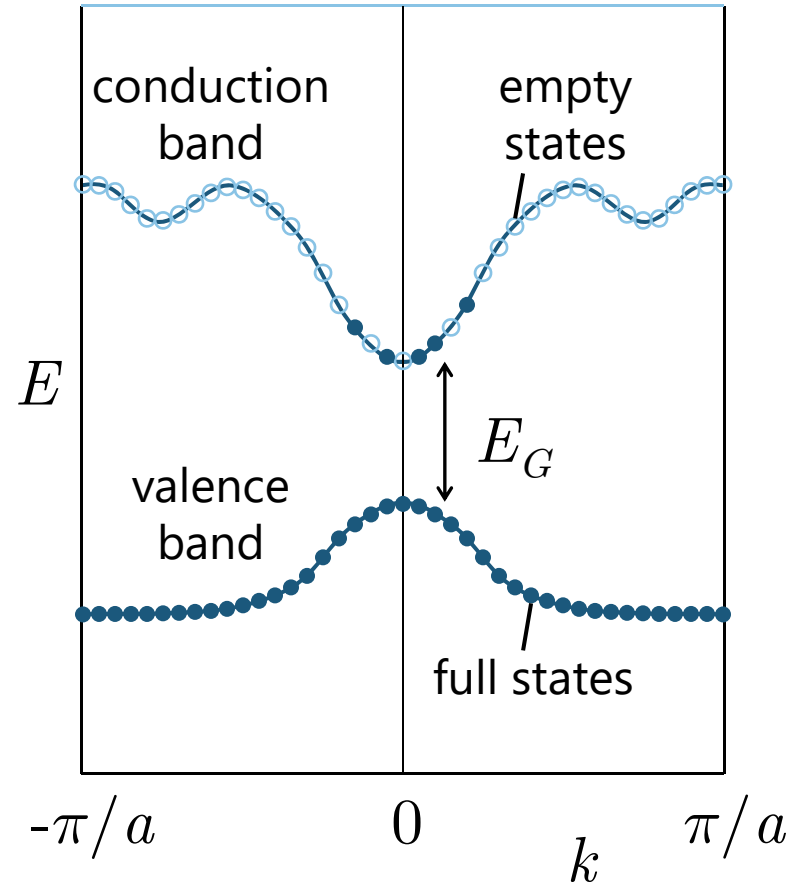
Doping semiconductors

Substituting a few atoms with more electrons

e.g., a Group V element like phosphorus in a Group IV semiconductor like silicon

known as n-type doping
makes the material conduct more

using these additional electrons

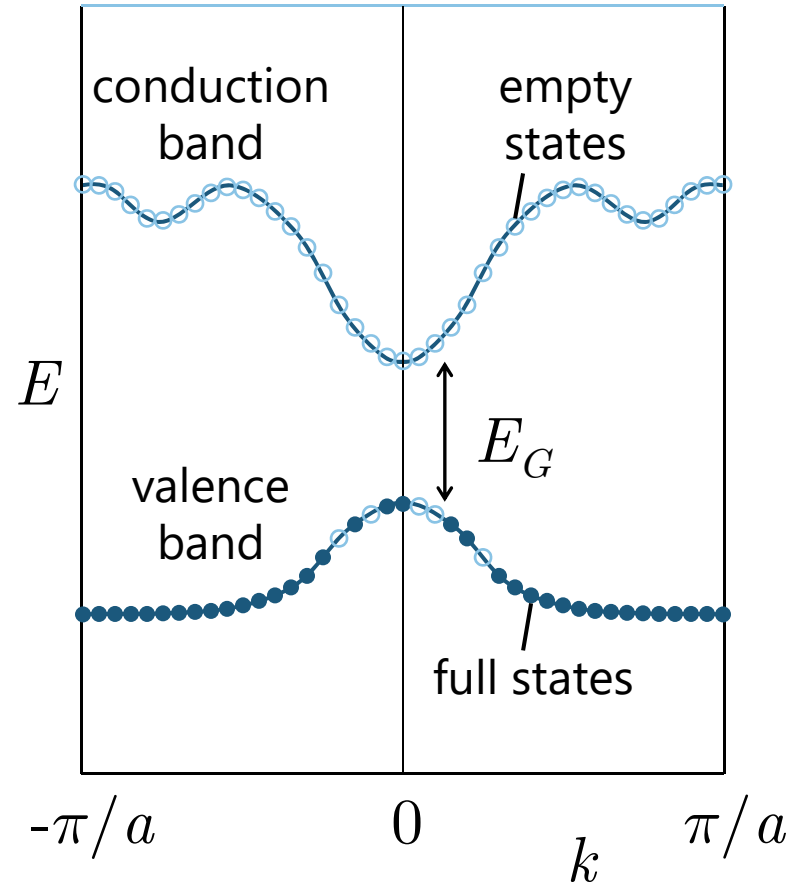


Doping semiconductors

Substituting a few atoms with fewer electrons

e.g., a Group III element like boron in a Group IV semiconductor like silicon known as p-type doping makes the material conduct more

using these additional "holes"



Semiconductor diodes

Semiconductor diode

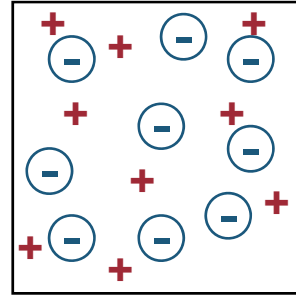
Conceptually, to make a diode

we join

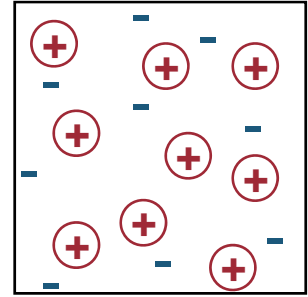
a piece of p-doped semiconductor
with ionized acceptors
and free holes

to

a piece of n-doped semiconductor
with ionized donors
and free electrons



p-type



n-type



ionized acceptor



ionized donor



free hole



free electron

Semiconductor diode

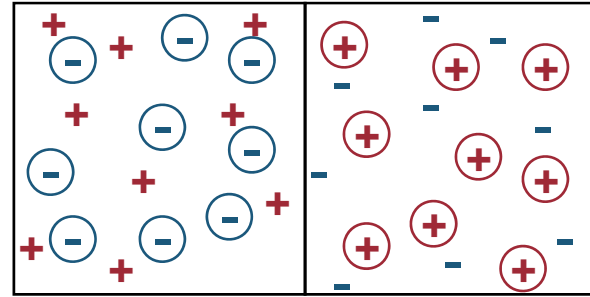
Conceptually, to make a diode

we join

a piece of p-doped semiconductor
with ionized acceptors
and free holes

to

a piece of n-doped semiconductor
with ionized donors
and free electrons



p-type

n-type



ionized acceptor



ionized donor



free hole



free electron

Semiconductor diode

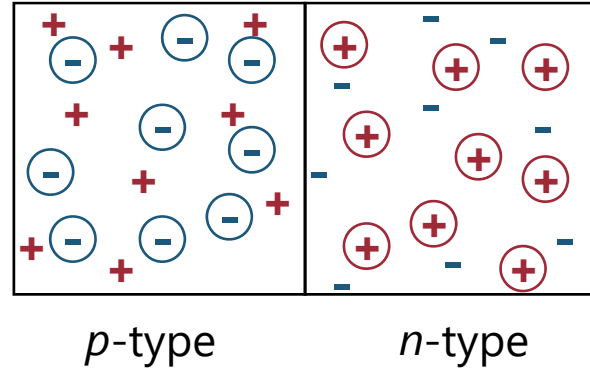
Once they are joined

free electrons move

from the side with more
to the side with less

by "diffusion"

and similarly for free holes



⊖ ionized acceptor

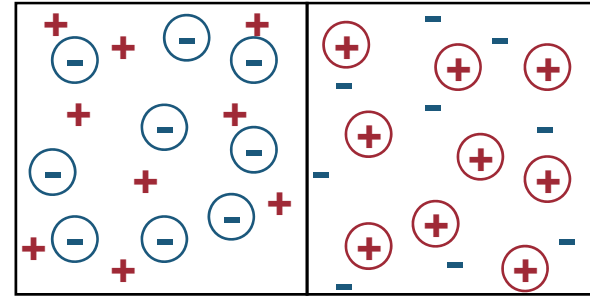
⊕ ionized donor

+ free hole

- free electron

Semiconductor diode

Diffusion is the process where
as a result of a "random walk"
there is net flow
from regions of high
concentration
to regions of low
concentration
like smoke diffusing through
a room



p-type

n-type

⊖ ionized acceptor

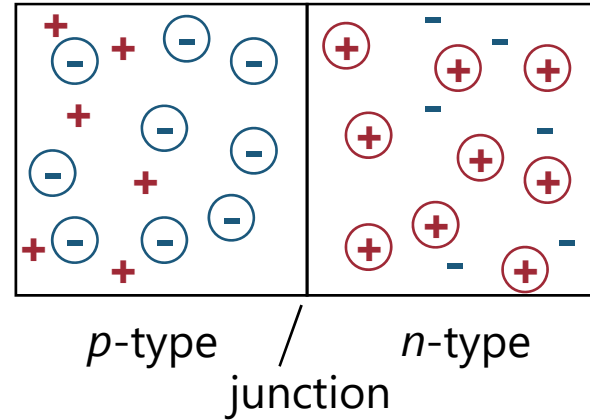
⊕ ionized donor





+ free hole

- free electron

Semiconductor diode

Free electrons and free holes
arriving in the same region as
a result of diffusion
effectively “annihilate” one
another by recombination



- | | | | |
|---|------------------|---|---------------|
|  | ionized acceptor |  | free hole |
|  | ionized donor |  | free electron |

Semiconductor diode

As the electrons and holes move
and "annihilate"

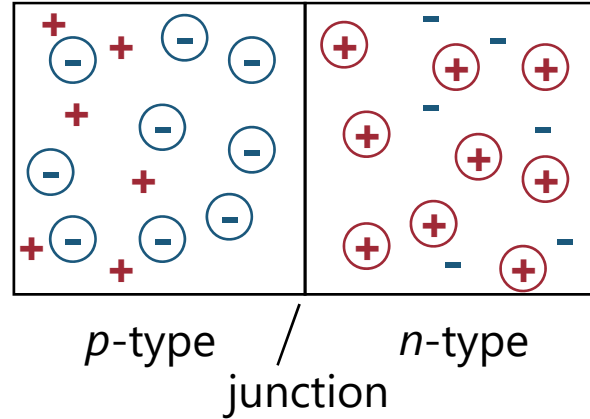
they leave behind net "bare"
fixed charges

the ionized donors and
acceptors

which means an electric
field is generated

in the direction that
opposes the diffusion

electric field
←



ionized acceptor



free hole



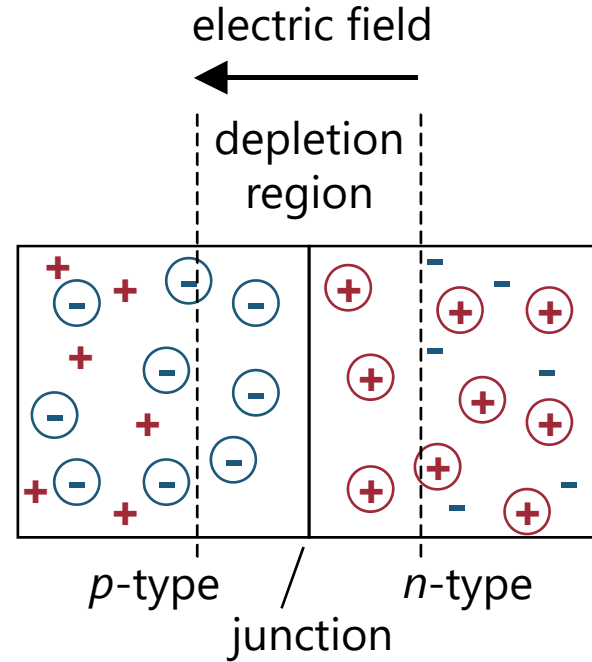
ionized donor







free electron

Semiconductor diode

The result is to create a
"depletion region"
on either side of the junction
with essentially no free
charges in it
and an electric field

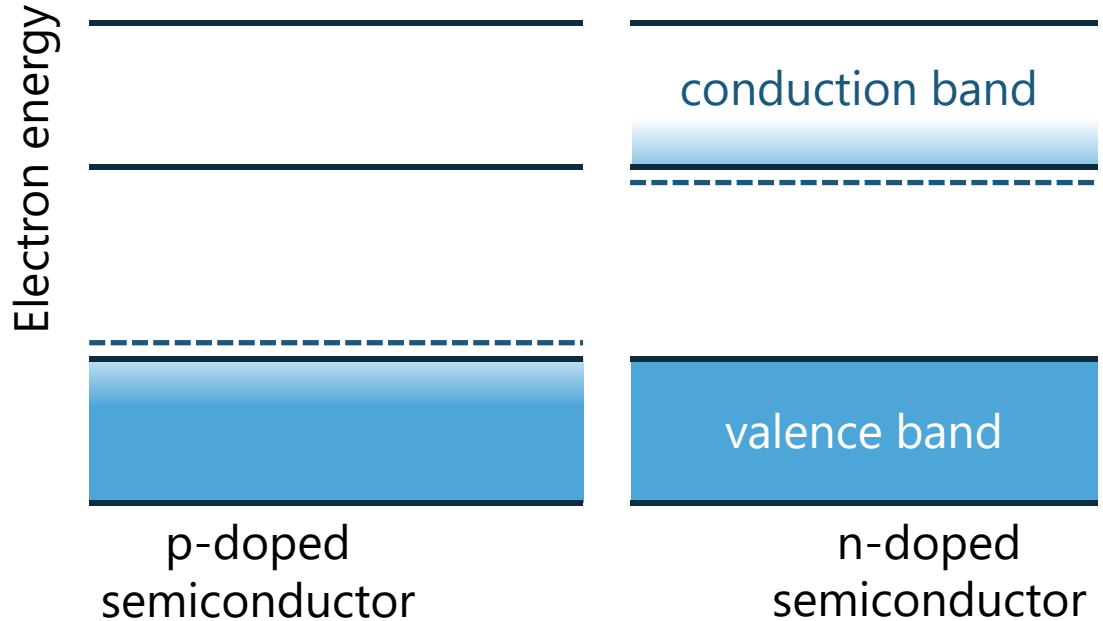


- | | | | |
|---|------------------|---|---------------|
|  | ionized acceptor |  | free hole |
|  | ionized donor |  | free electron |

Semiconductor diode

In terms of bands

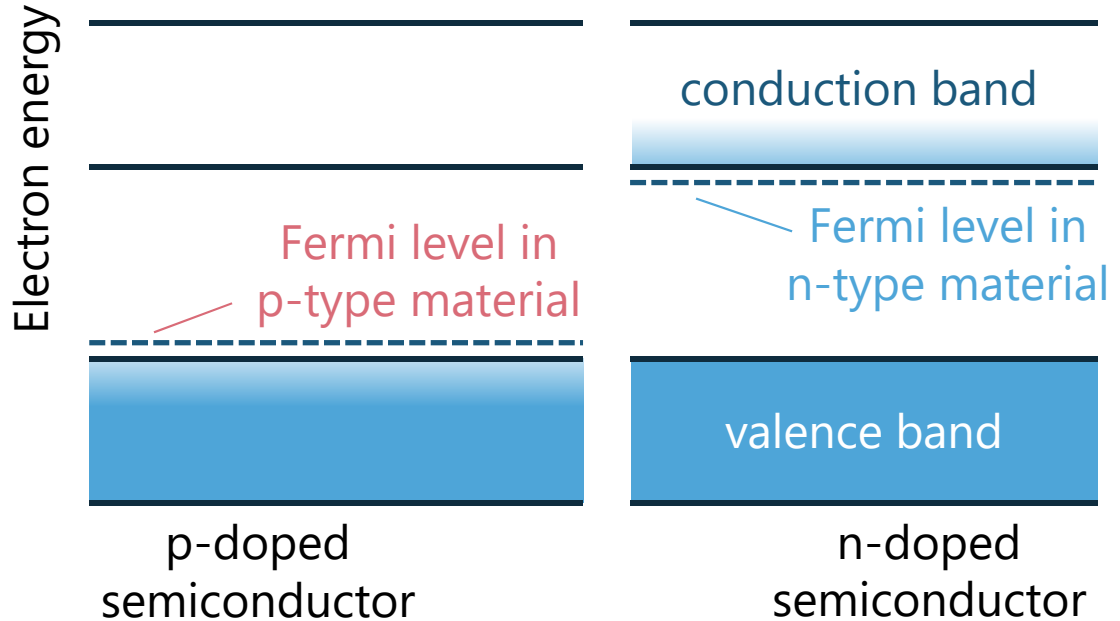
we might view the
bands as being
“lined up” before this
diffusion



Semiconductor diode

Before diffusion, the Fermi level must be

- near the conduction band edge in n-type material
- to have many electrons in the conduction band
- near the valence band edge in p-type material
- to have many holes in the valence band



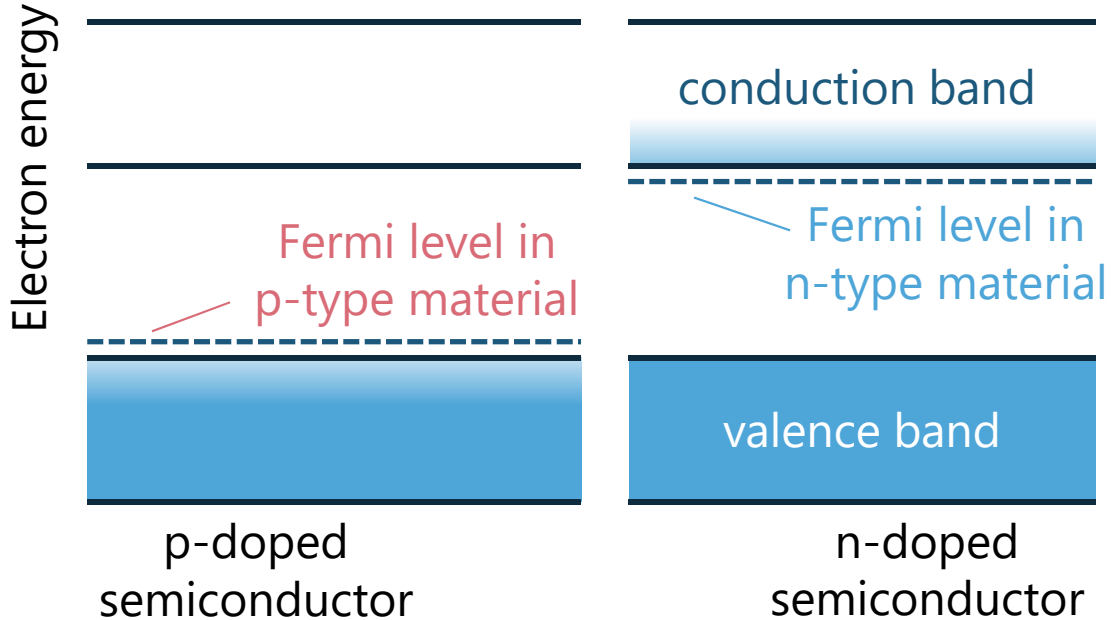
Semiconductor diode

Note that we move the Fermi level

closer to the valence band
by adding p-type
dopants

closer to the conduction
band

by adding n-type
dopants



Semiconductor diode

After the diffusion

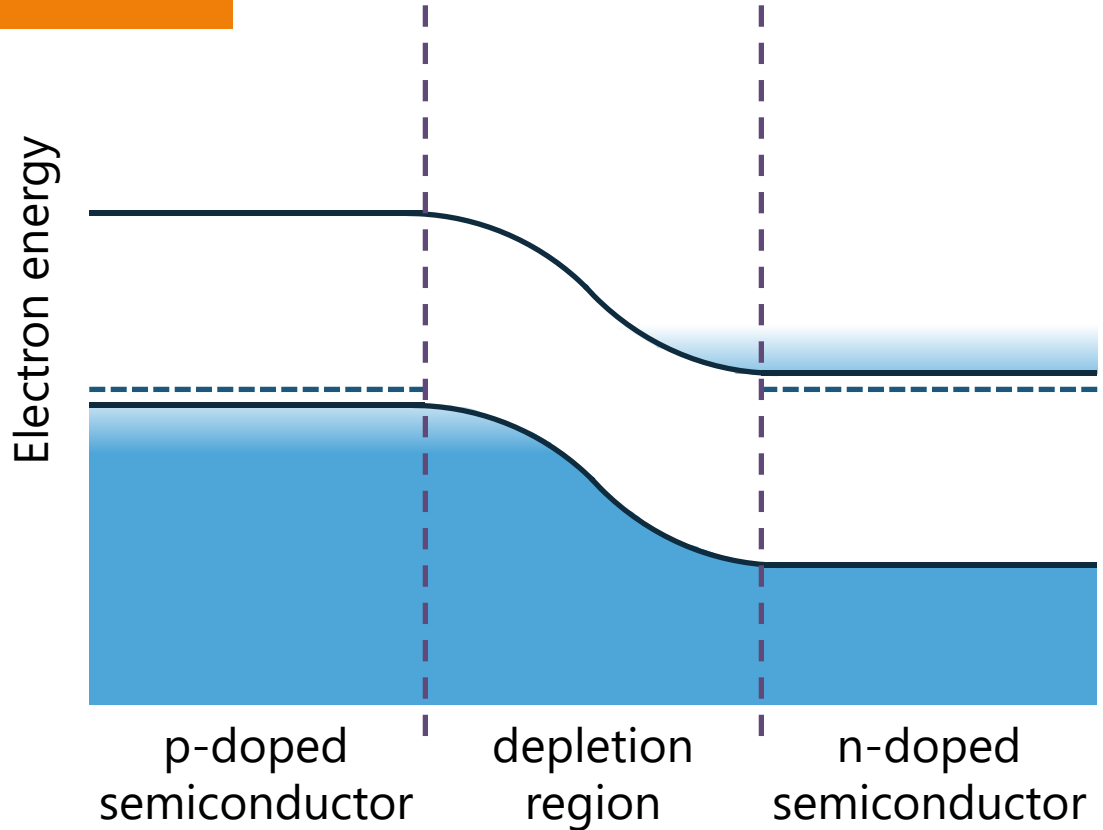
the electrostatic potential
has

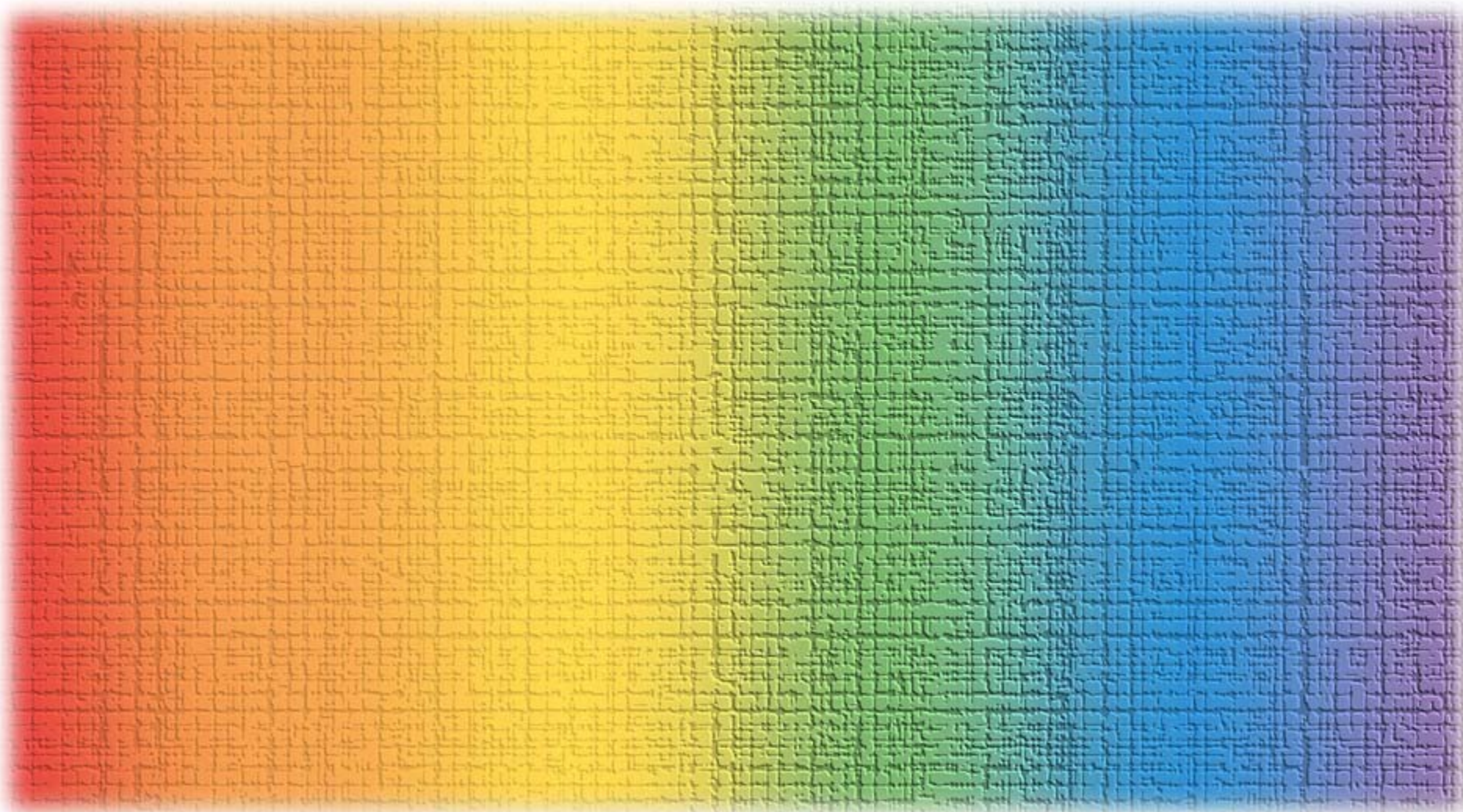
"bent" the bands

Formally

once the diffusion is
finished

the "Fermi levels" or
"chemical potentials"
are equalized







Bands and electronic devices

Voltages and Fermi levels

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Voltages and Fermi levels

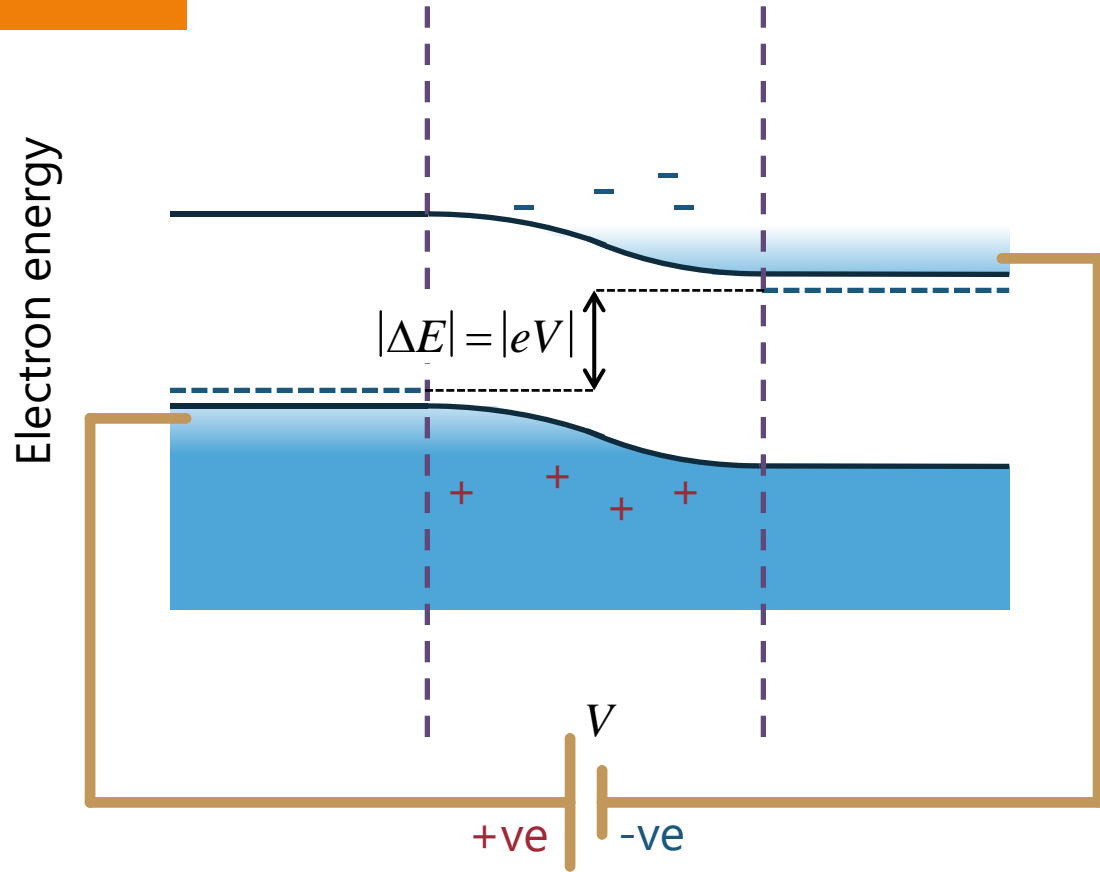
Why is it that

when we apply a voltage V between the two sides of a diode

we separate the Fermi levels

by an amount

$$|\Delta E| = |eV| \text{ ?}$$



Voltages and Fermi levels

To understand this

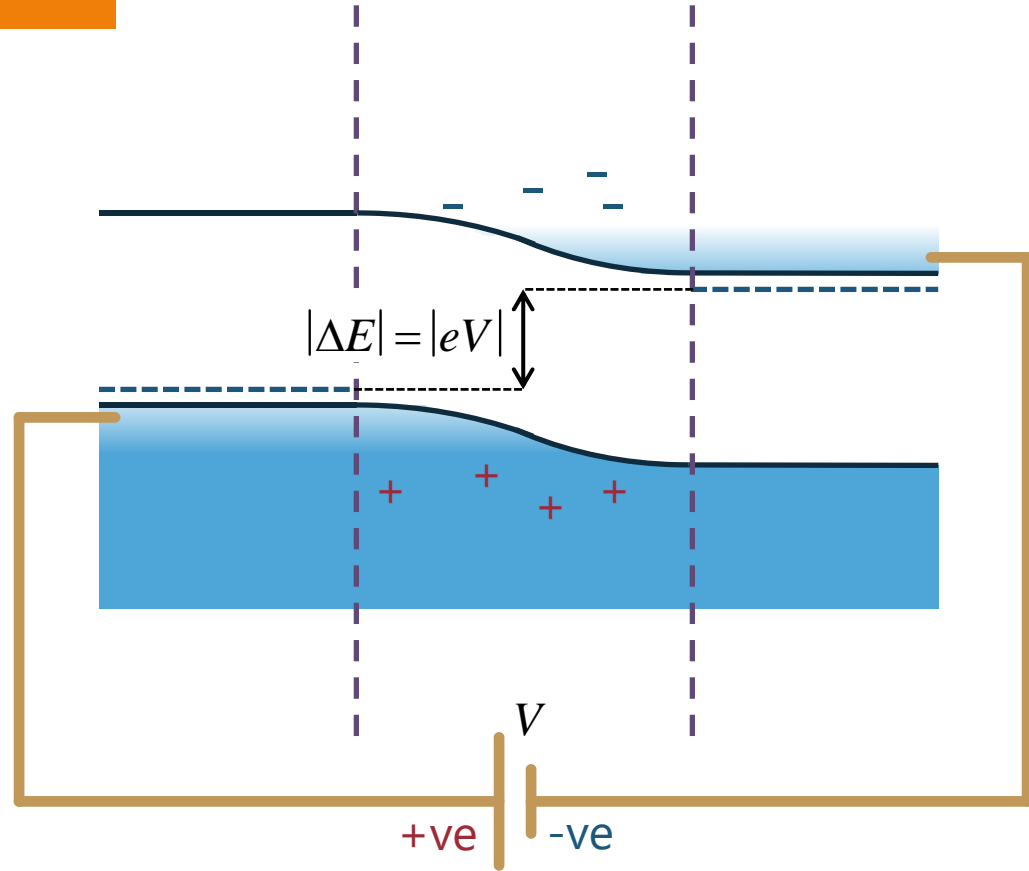
we need an alternate
but equivalent

definition of chemical
potential

$$\mu_c = \left(\frac{\partial U}{\partial N} \right) \bigg|_s \left(\equiv -\tau \left(\frac{\partial \sigma}{\partial N} \right) \bigg|_U \right)$$

where U is energy

Electron energy

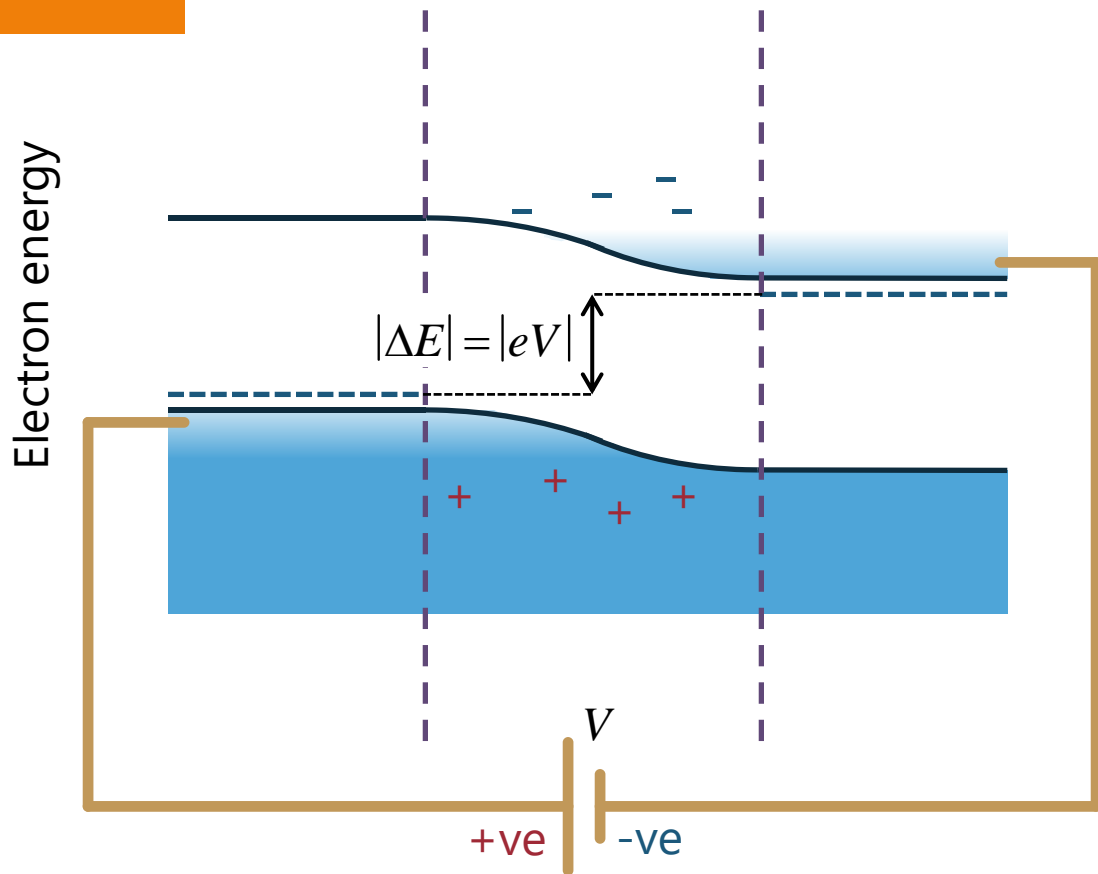


Voltages and Fermi levels

First, we can understand why this alternative form

$$\mu_c = \left(\frac{\partial U}{\partial N} \right) \bigg|_s$$

gives the result we need



Voltages and Fermi levels

Note that $\left(\frac{\partial U}{\partial N}\right)_S$ is

the energy per particle at constant entropy

Adding a potential energy $|\Delta E| = |eV|$ to every electron
by changing the voltage V

changes the energy per particle by $|\Delta E| = |eV|$
without changing the entropy at all

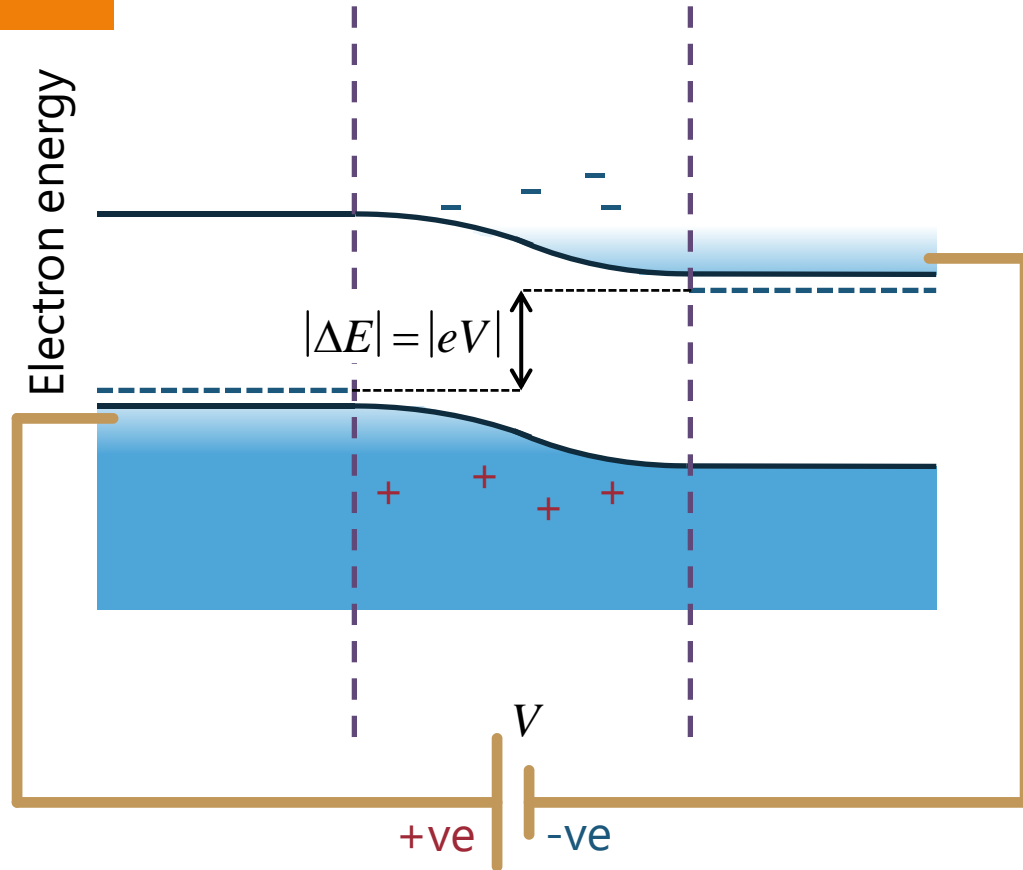
and hence changes the chemical potential

$$\mu_c = \left(\frac{\partial U}{\partial N}\right)_S \text{ by the same amount}$$

Q.E.D

Voltages and Fermi levels

Hence adding $|\Delta E| = |eV|$
to each electron on the
"right"
compared to the electrons
on the "left"
raises the Fermi level
(chemical potential) on
the "right" by $|\Delta E| = |eV|$
compared to that on
the "left"



Proof of equivalence of chemical potential definitions

Consider the differential of entropy $d\sigma$ for a system with energy U and particle number N

Then, considering a situation of constant entropy, we would have

$$d\sigma = \left(\frac{\partial \sigma}{\partial U} \right) \bigg|_N dU + \left(\frac{\partial \sigma}{\partial N} \right) \bigg|_U dN = 0$$

So, at such a constant entropy, we have

$$\left(\frac{\partial \sigma}{\partial U} \right) \bigg|_N dU = - \left(\frac{\partial \sigma}{\partial N} \right) \bigg|_U dN$$

Proof of equivalence of chemical potential definitions

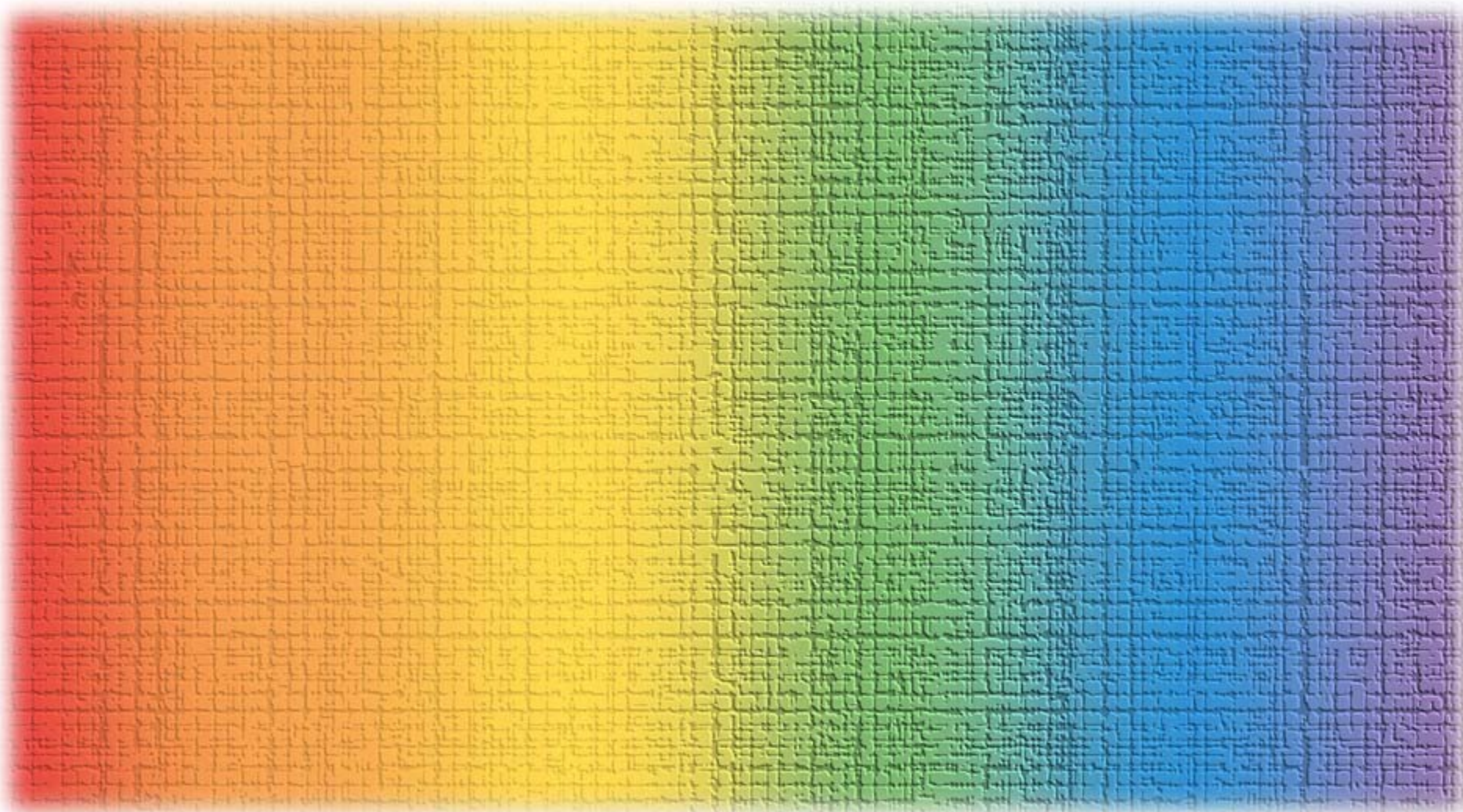
With $\left(\frac{\partial \sigma}{\partial U}\right)\bigg|_N dU = -\left(\frac{\partial \sigma}{\partial N}\right)\bigg|_U dN$ at constant entropy

we can therefore write $\left(\frac{\partial \sigma}{\partial U}\right)\bigg|_N \left(\frac{\partial U}{\partial N}\right)\bigg|_S = -\left(\frac{\partial \sigma}{\partial N}\right)\bigg|_U$

But $\left(\frac{\partial \sigma}{\partial U}\right)\bigg|_N \equiv \frac{1}{\tau}$

So $\left(\frac{\partial U}{\partial N}\right)\bigg|_S = -\tau \left(\frac{\partial \sigma}{\partial N}\right)\bigg|_U = \mu_C$

which is the chemical potential – Q. E. D.





Bands and electronic devices

Biasing semiconductor devices

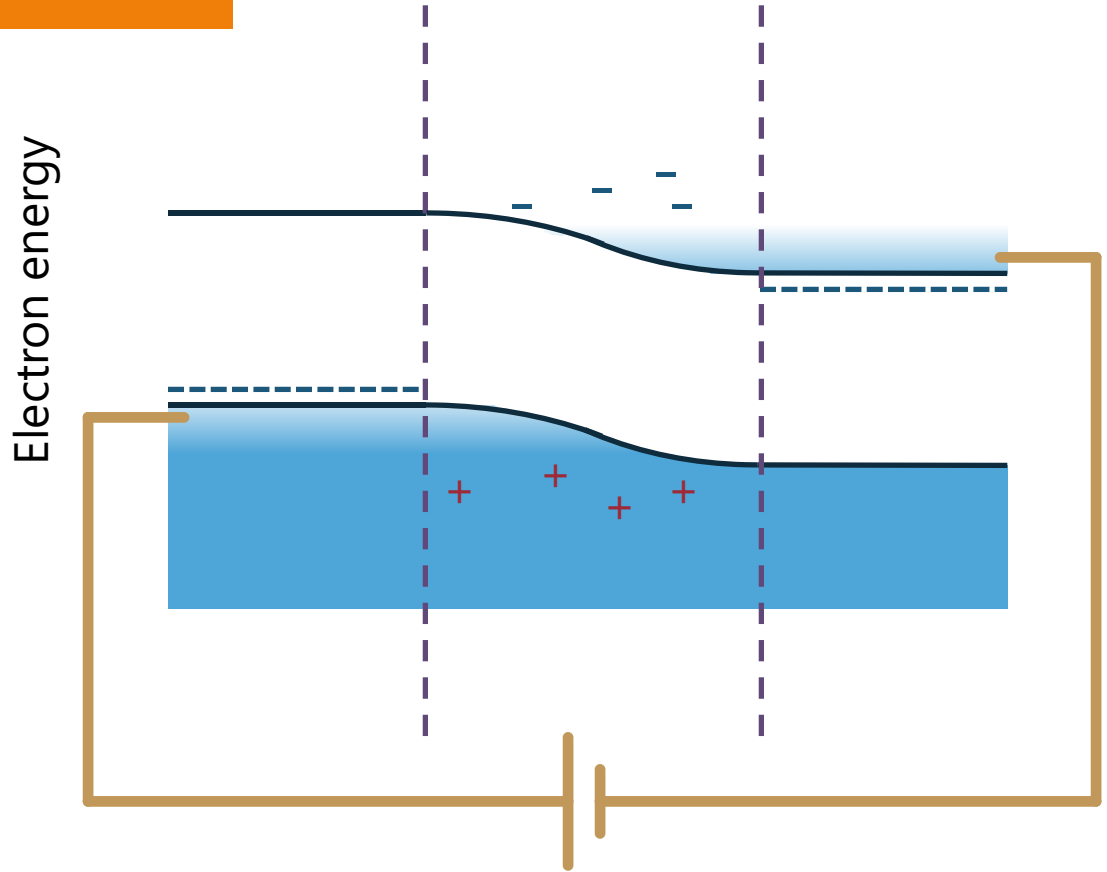
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Biasing semiconductor diodes

Semiconductor diode

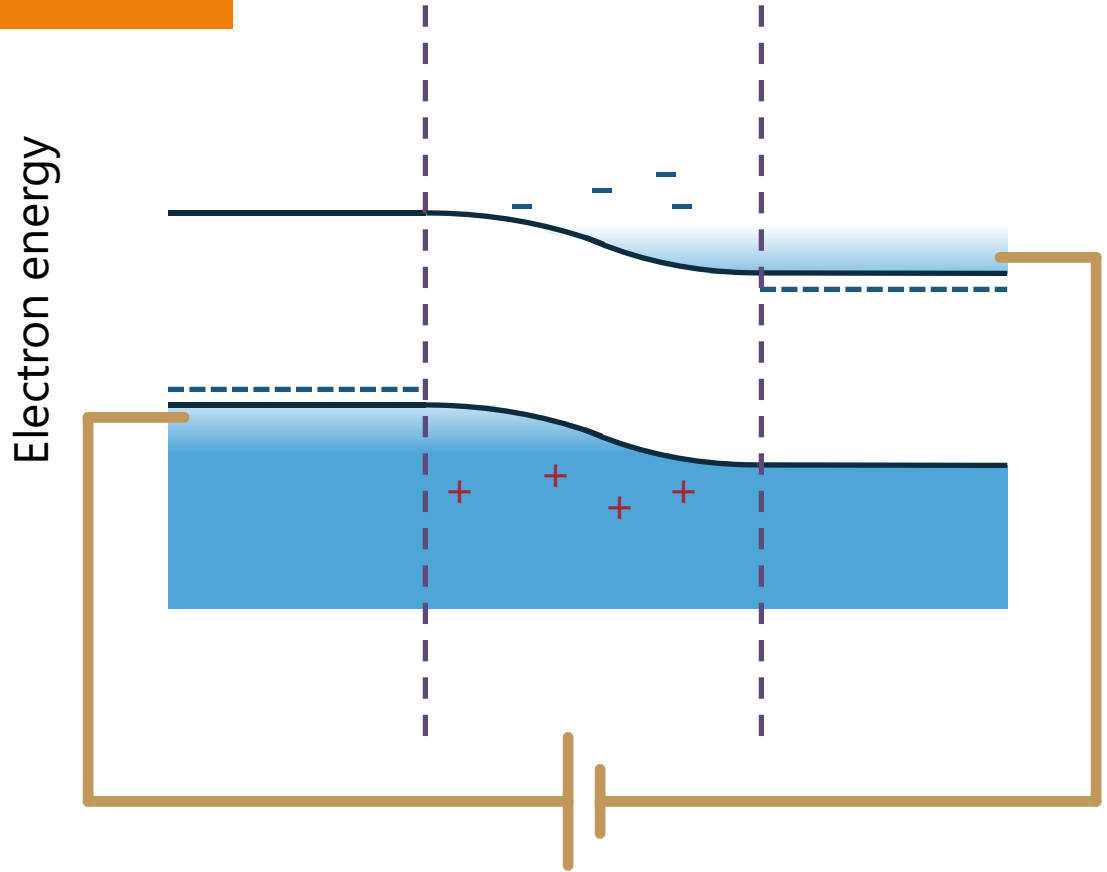
"Forward biasing"
"unbalances" the
diffusion again
allowing electrons
with enough
thermal energy
to diffuse from
right to left
over the
potential



Semiconductor diode

and allowing holes
with enough
thermal energy
to diffuse from
left to right
"over" the
potential

This diffusion current is
the normal diode
forward current



Reverse-biased diode

In a reverse-biased diode

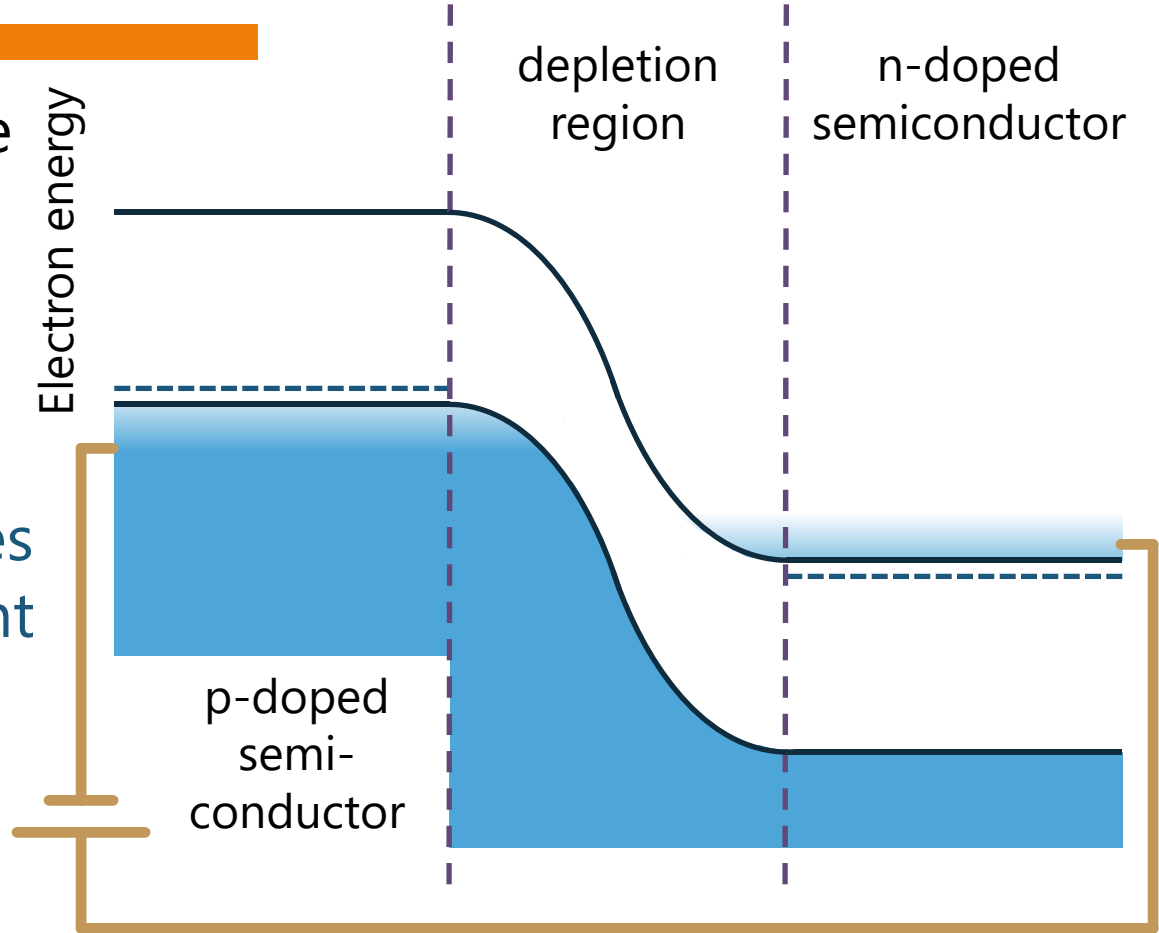
the barriers

for conduction band
electrons to diffuse
to the left, and

for valence band holes
to diffuse to the right

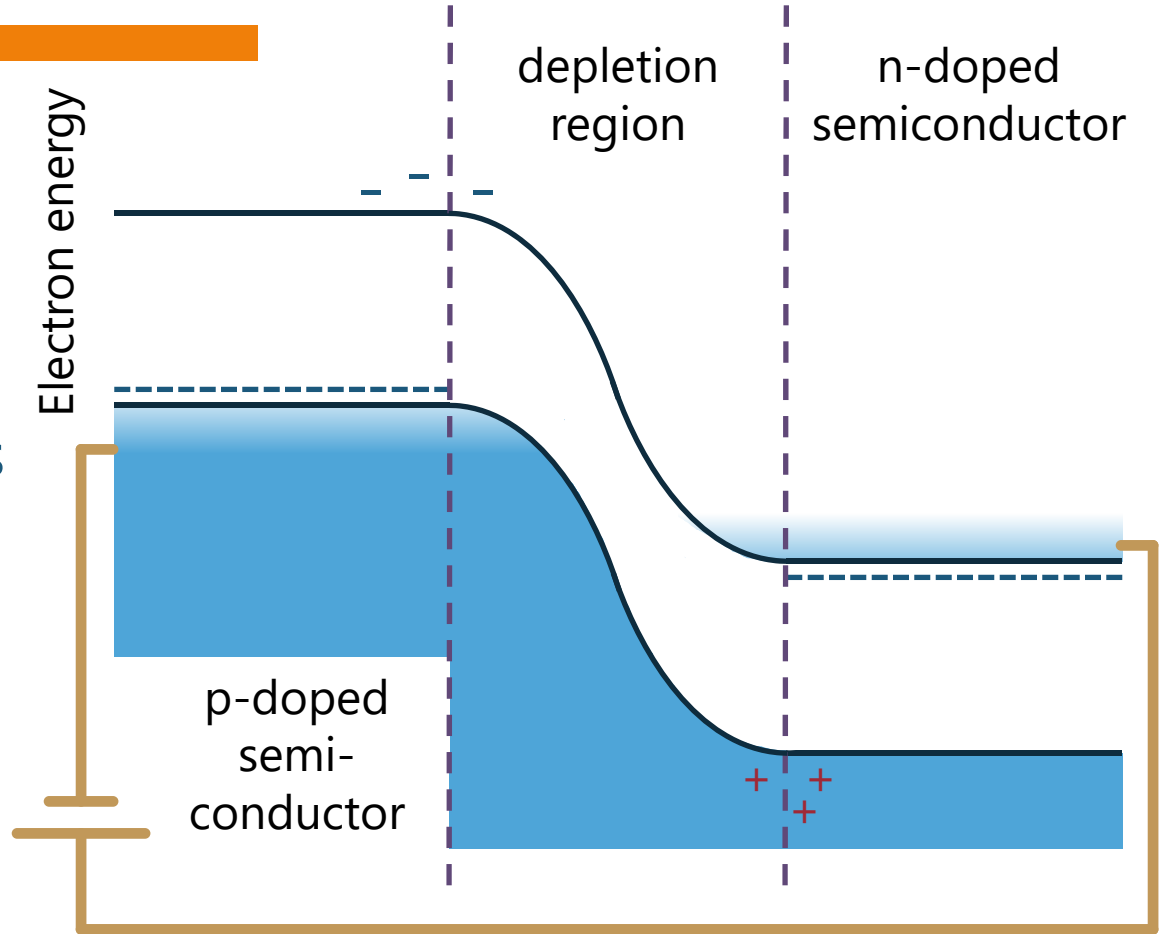
are even higher

turning off forward
diffusion current



Reverse-biased diode

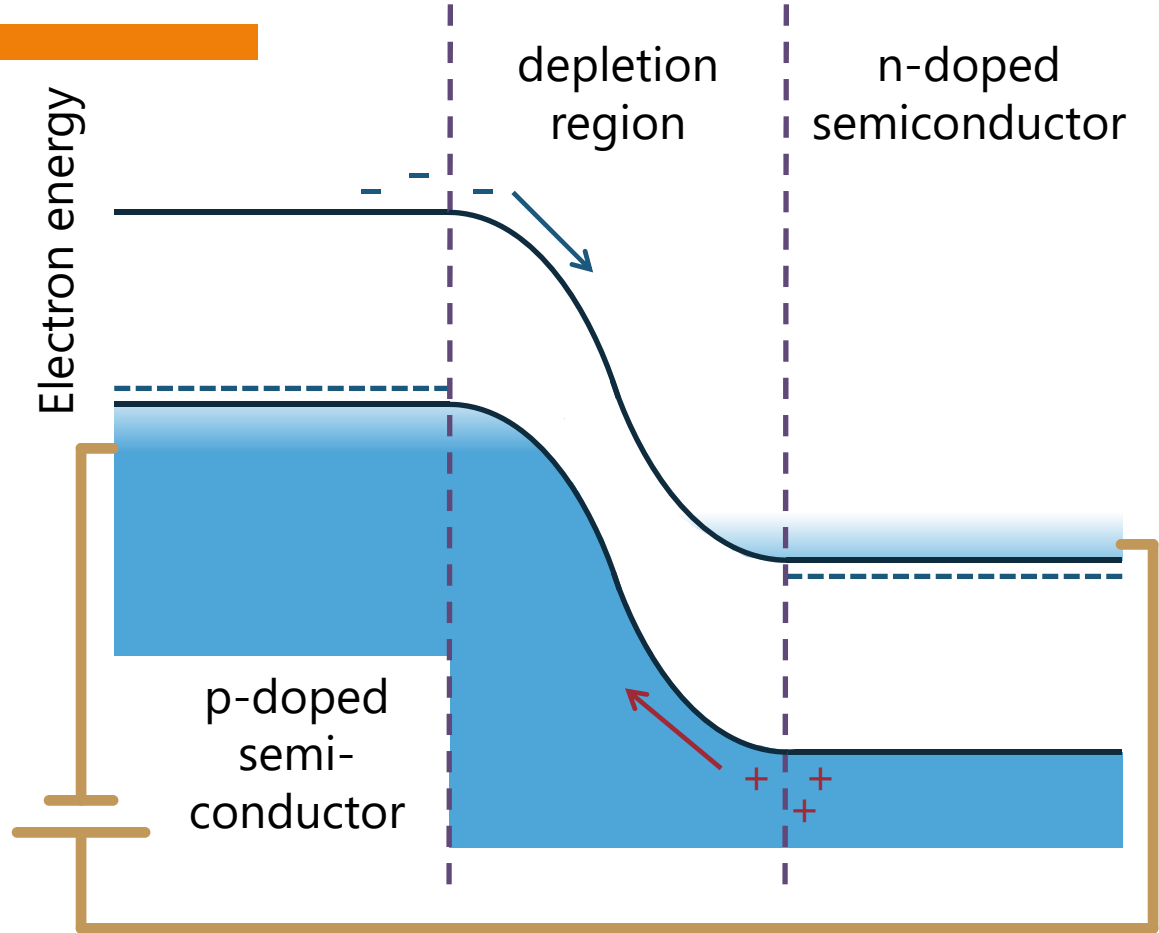
At a finite temperature there are also very small "minority carrier" densities of conduction electrons in the p-semiconductor and valence holes in the n-semiconductor



Reverse-biased diode

These minority carriers
can diffuse into the
depletion region
and drift down-hill

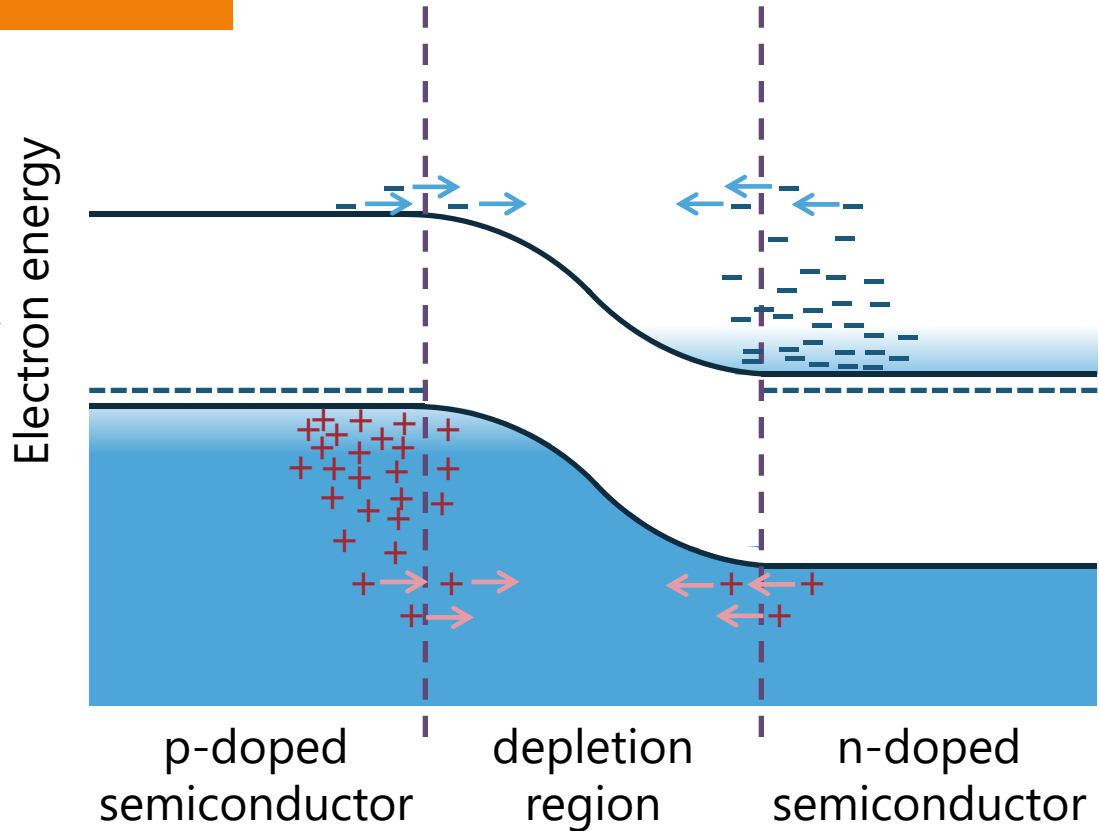
Under reverse bias
this gives reverse
leakage current
of magnitude I_s
present even in an
ideal diode



Semiconductor diode current-voltage characteristic

Current at zero bias voltage

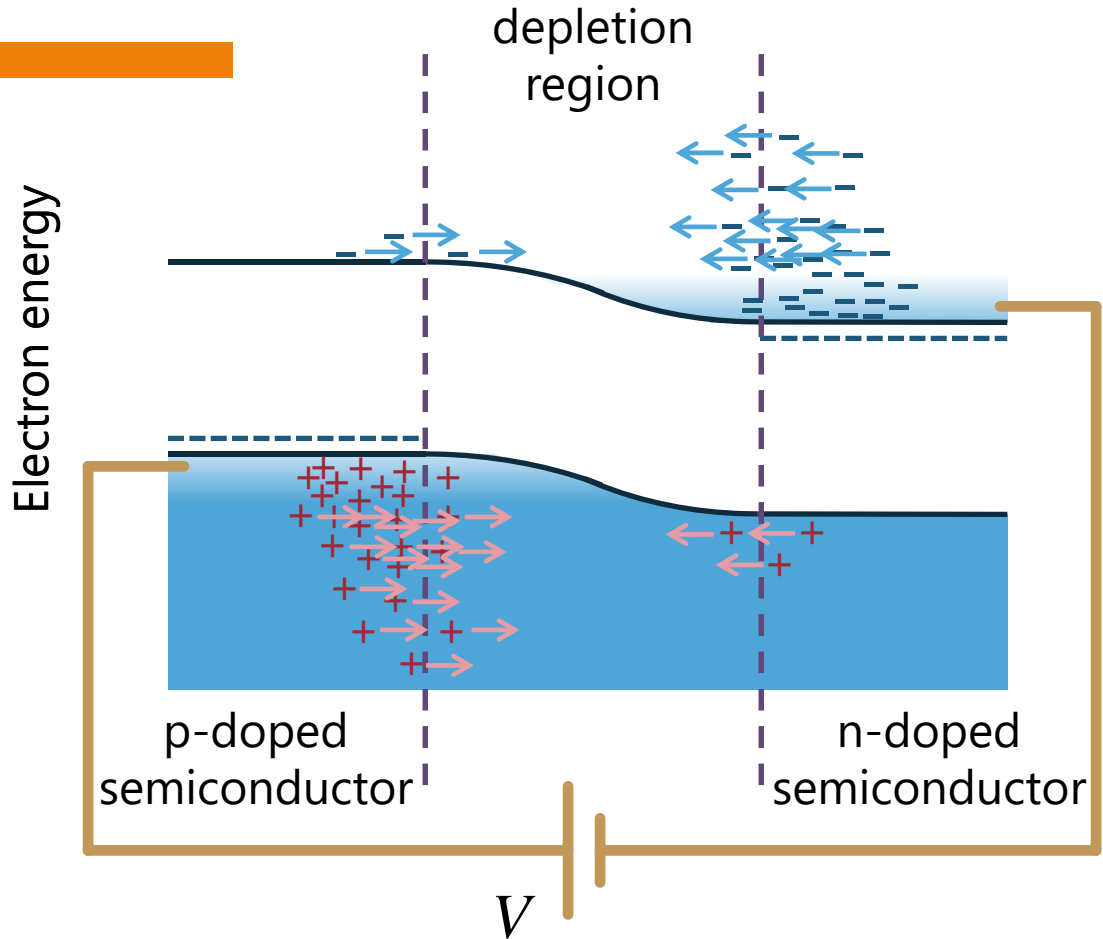
At zero bias voltage
the number of
minority carriers
diffusing in "reverse"
equals the number of
"majority carriers"
diffusing "forwards"
electrons on the n
side
holes in the p side



Net forward current

Under forward bias by V volts

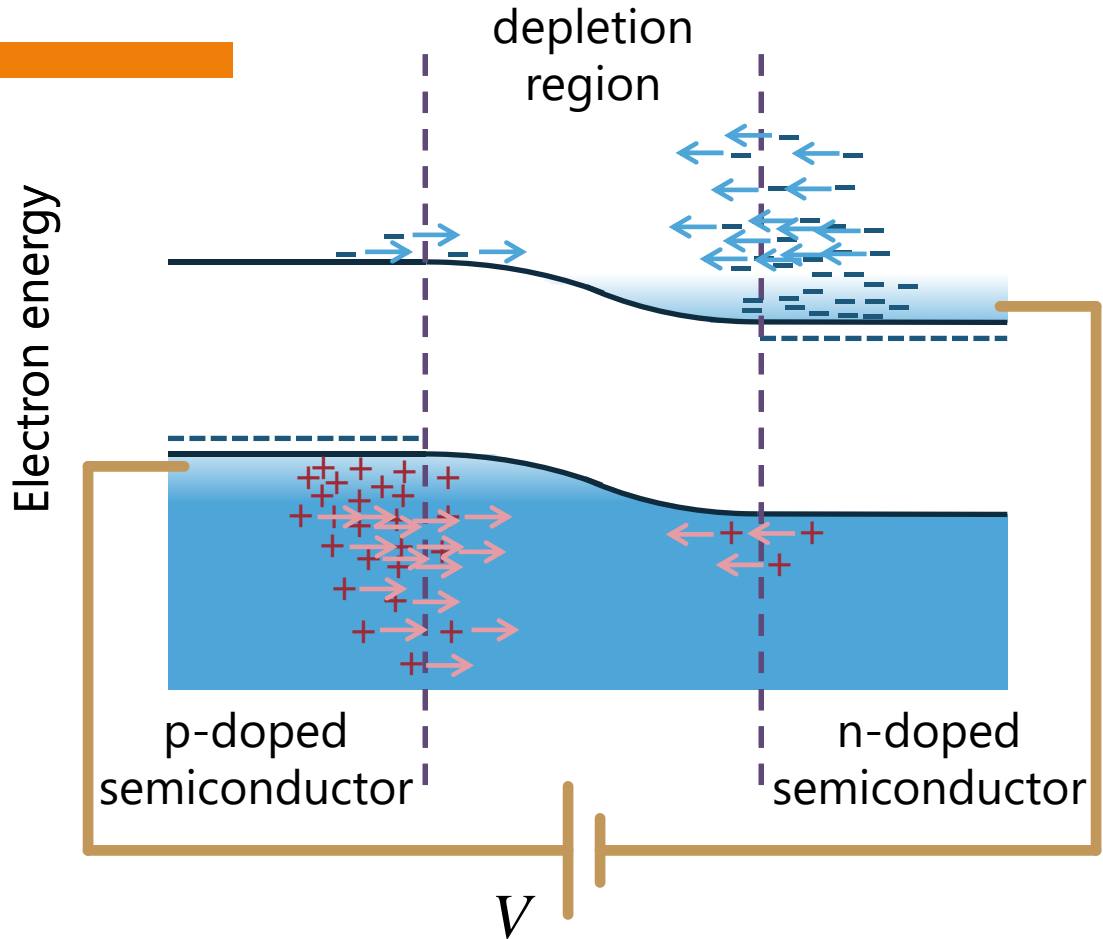
the occupation probability of the majority carrier states presuming the Maxwell-Boltzmann approximation has increased by $\exp(eV / k_B T)$



Net forward current

So the net forward current I in a diode is
the forward diffusion
minus
the backward
"leakage" diffusion

$$I = I_S \left[\exp\left(\frac{eV}{k_B T}\right) - 1 \right]$$



Diode current-voltage (I-V)

Here is current as a function of voltage for an “ideal” diode

At room temperature

$$k_B T / e \simeq 25 \text{ mV}$$

I_S depends on doping levels
and material properties

$$I = I_S \left[\exp\left(\frac{eV}{k_B T}\right) - 1 \right]$$

